



# RF LDMOS Wideband Integrated Power Amplifiers

The MW6IC2240N wideband integrated circuit is designed with on-chip matching that makes it usable from 2110 to 2170 MHz. This multi-stage structure is rated for 26 to 32 Volt operation and covers all typical cellular base station modulation formats including TD-SCDMA.

## Final Application

- Typical 2-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ1} = 210$  mA,  $I_{DQ2} = 370$  mA,  $P_{out} = 4.5$  Watts Avg., Full Frequency Band (2110-2170 MHz), Channel Bandwidth = 3.84 MHz, PAR = 8.5 dB @ 0.01% Probability on CCDF.  
 Power Gain — 28 dB  
 Power Added Efficiency — 15%  
 IM3 @ 10 MHz Offset — -43 dBc in 3.84 MHz Bandwidth  
 ACPR @ 5 MHz Offset — -46 dBc in 3.84 MHz Bandwidth

## Driver Application

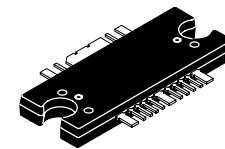
- Typical 2-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ1} = 300$  mA,  $I_{DQ2} = 320$  mA,  $P_{out} = 25$  dBm, Full Frequency Band (2110-2170 MHz), Channel Bandwidth = 3.84 MHz, PAR = 8.5 dB @ 0.01% Probability on CCDF.  
 Power Gain — 29 dB  
 IM3 @ 10 MHz Offset — -59 dBc in 3.84 MHz Bandwidth  
 ACPR @ 5 MHz Offset — -62 dBc in 3.84 MHz Bandwidth
- Capable of Handling 3:1 VSWR, @ 28 Vdc, 2170 MHz, 20 Watts CW Output Power
- Stable into a 3:1 VSWR. All Spurs Below -60 dBc @ 100 mW to 10 Watts CW  $P_{out}$ .

## Features

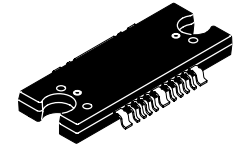
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source Scattering Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked, >3 Ohm Output)
- Integrated Quiescent Current Temperature Compensation with Enable/Disable Function
- Integrated ESD Protection
- 200°C Capable Plastic Package
- N Suffix Indicates Lead-Free Terminations. RoHS Compliant.
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel

**MW6IC2240NBR1**  
**MW6IC2240GNBR1**

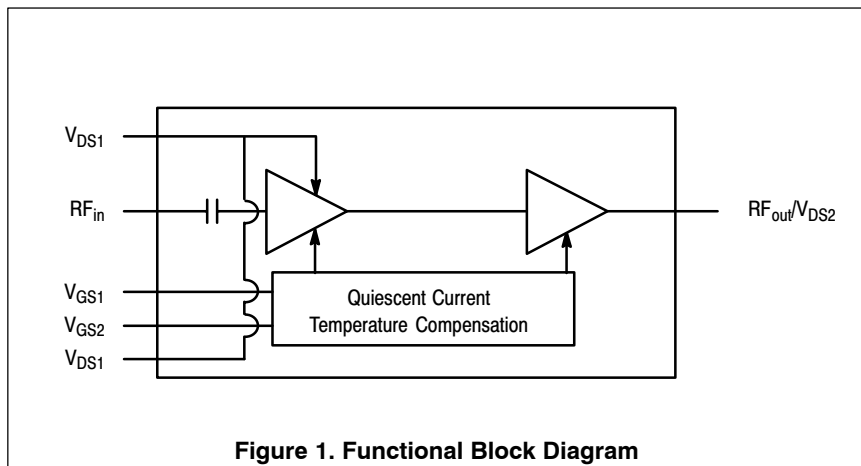
**2110-2170 MHz, 4.5 W AVG., 28 V**  
**2 x W-CDMA**  
**RF LDMOS WIDEBAND**  
**INTEGRATED POWER AMPLIFIERS**



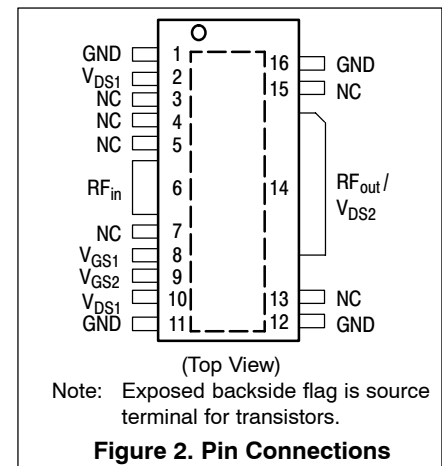
**CASE 1329-09**  
**TO-272 WB-16**  
**PLASTIC**  
**MW6IC2240NBR1**



**CASE 1329A-03**  
**TO-272 WB-16 GULL**  
**PLASTIC**  
**MW6IC2240GNBR1**



**Figure 1. Functional Block Diagram**



**Figure 2. Pin Connections**

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +68	Vdc
Gate-Source Voltage	$V_{GS}$	-0.5, +6	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +200	°C
Operating Junction Temperature	$T_J$	200	°C
Input Power	$P_{in}$	23	dBm

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$		°C/W
W-CDMA Application ( $P_{out} = 4.5$ W Avg.)	Stage 1, 28 Vdc, $I_{DQ} = 210$ mA Stage 2, 28 Vdc, $I_{DQ} = 370$ mA	1.8 1.0	
W-CDMA Application ( $P_{out} = 40$ W CW)	Stage 1, 28 Vdc, $I_{DQ} = 110$ mA Stage 2, 28 Vdc, $I_{DQ} = 370$ mA	2.0 0.87	

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	1A (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	III (Minimum)

**Table 4. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

**Table 5. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Power Gain	$G_{ps}$	25.5	28	30	dB
Power Added Efficiency	PAE	13.7	15	—	%
Intermodulation Distortion	IM3	—	-43	-40	dBc
Adjacent Channel Power Ratio	ACPR	—	-46	-43	dBc
Input Return Loss	IRL	—	-15	-10	dB

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

(continued)

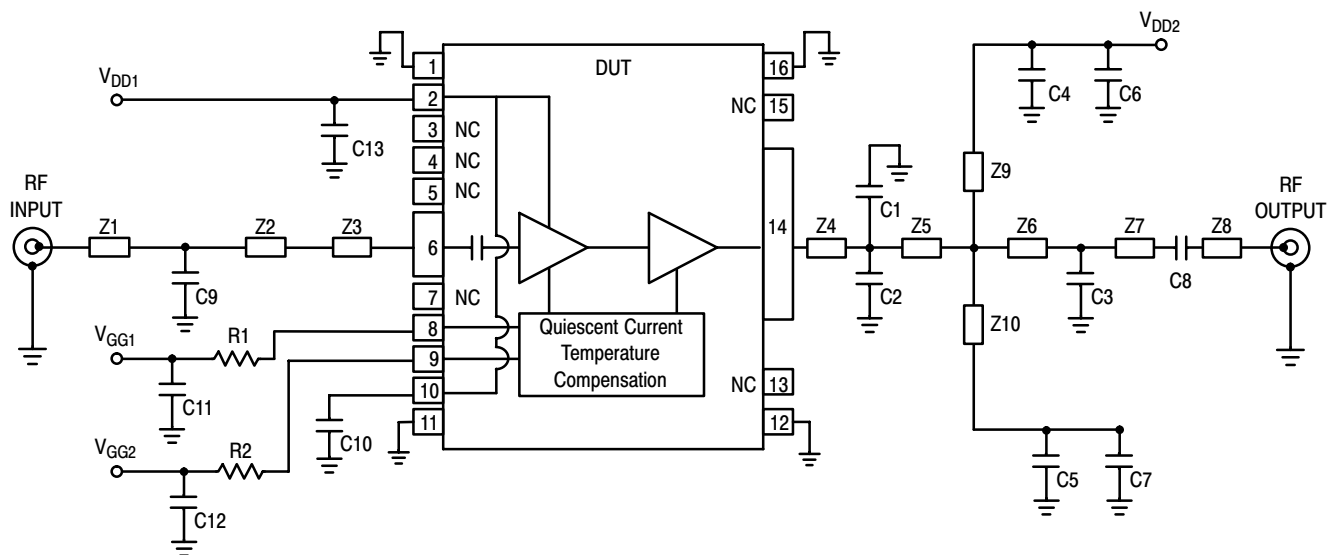
**Table 5. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$ , $I_{DQ1} = 210\text{ mA}$ , $I_{DQ2} = 370\text{ mA}$ , 2110 MHz < Frequency < 2170 MHz					
Video Bandwidth (Tone Spacing from 100 kHz to VBW) $\Delta\text{IMD3} = \text{IMD3 @ VBW frequency} - \text{IMD3 @ 100 kHz} < 1\text{ dBc}$ (both sidebands)	VBW	—	30	—	MHz
Quiescent Current Accuracy over Temperature with 18 k $\Omega$ Gate Feed Resistors (-10 to 85°C) (1)	$\Delta I_{QT}$	—	$\pm 5$	—	%
Gain Flatness in 30 MHz Bandwidth @ $P_{out} = 1\text{ W CW}$	$G_F$	—	0.2	—	dB
Deviation from Linear Phase in 30 MHz Bandwidth @ $P_{out} = 1\text{ W CW}$	$\Phi$	—	$\pm 1$	—	°
Delay @ $P_{out} = 1\text{ W CW}$ Including Output Matching	Delay	—	2.8	—	ns
Part-to-Part Phase Variation @ $P_{out} = 1\text{ W CW}$	$\Delta\Phi$	—	$\pm 9$	—	°

**Table 6. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$ , $I_{DQ1} = 110\text{ mA}$ , $I_{DQ2} = 370\text{ mA}$ , 2110 MHz < Frequency < 2170 MHz					
Saturated Pulsed Output Power (8 $\mu\text{sec}$ (on), 1 $\text{msec}$ (off))	$P_{sat}$	—	60	—	W

1. Refer to AN1977, *Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1977.



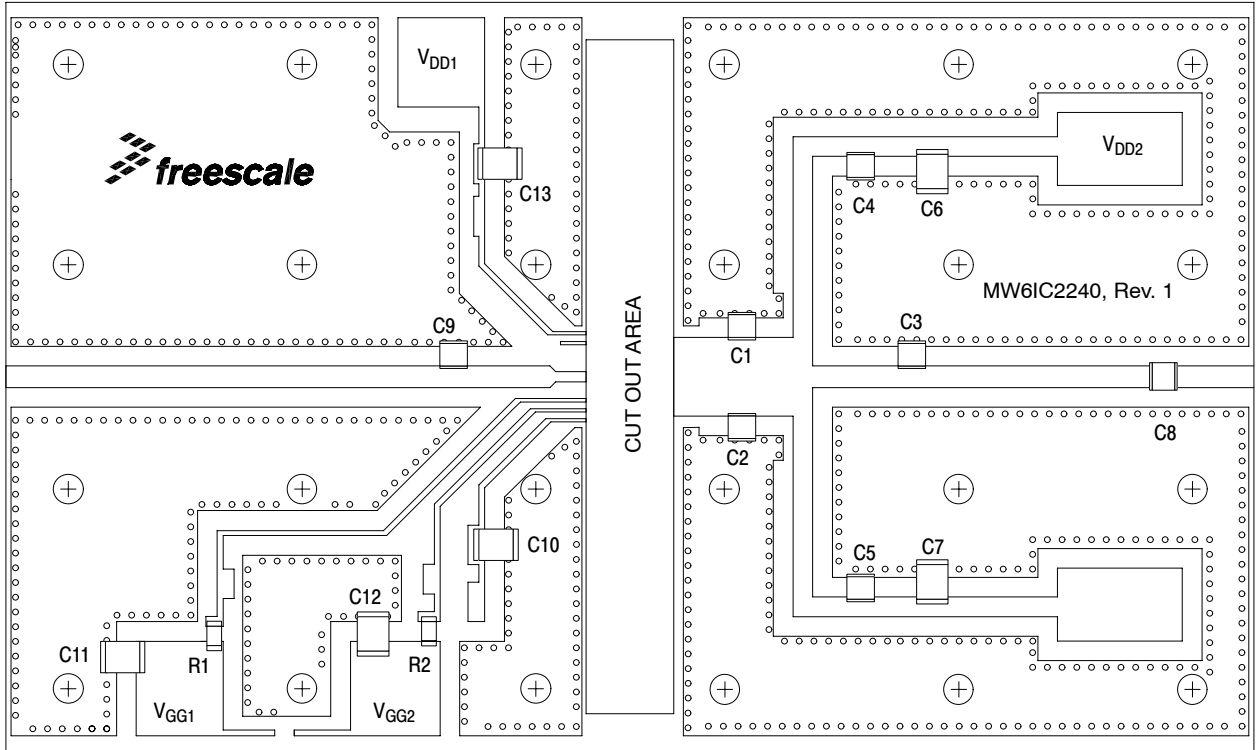
Z1\* 1.73" x 0.090" Microstrip  
 Z2\* 0.47" x 0.090" Microstrip  
 Z3 0.13" x 0.040" Microstrip  
 Z4\* 0.22" x 0.315" Microstrip  
 Z5\* 0.34" x 0.315" Microstrip  
 Z6\* 0.34" x 0.090" Microstrip

Z7\* 0.94" x 0.090" Microstrip  
 Z8 0.34" x 0.090" Microstrip  
 Z9, Z10 1.00" x 0.080" Microstrip  
 PCB Taconic TLX8-0300, 0.030",  $\epsilon_r = 2.55$   
 \* Variable for tuning

Figure 3. MW6IC2240NBR1(GNBR1) Test Circuit Schematic

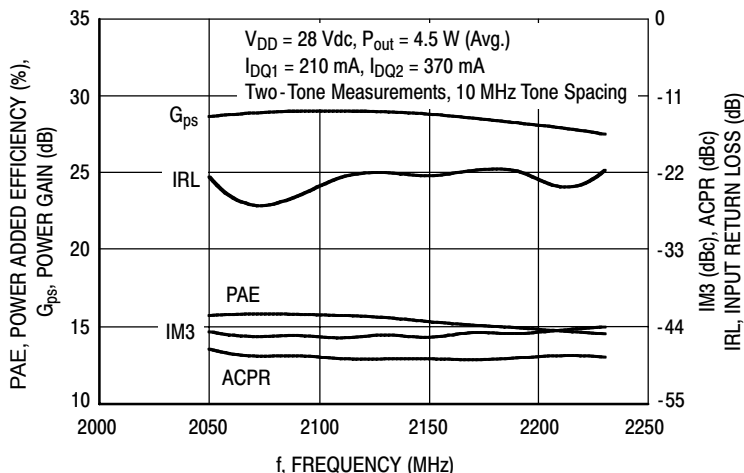
Table 7. MW6IC2240NBR1(GNBR1) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2	1.5 pF Chip Capacitors	ATC100B1R5BT500XT	ATC
C3	1.8 pF Chip Capacitor	ATC100B1R8BT500XT	ATC
C4, C5	6.8 pF Chip Capacitors	ATC100B6R8CT500XT	ATC
C6, C7, C10, C11, C12, C13	4.7 $\mu$ F Chip Capacitors	C4532X5R1H475MT	TDK
C8	8.2 pF Chip Capacitor	ATC100B8R2CT500XT	ATC
C9	0.5 pF Chip Capacitor	ATC100B0R5BT500XT	ATC
R1	18 k $\Omega$ , 1/4 W Chip Resistor	CRCW120618R0FKTA	Vishay
R2	8.2 k $\Omega$ , 1/4 W Chip Resistor	CRCW12068201FKTA	Vishay

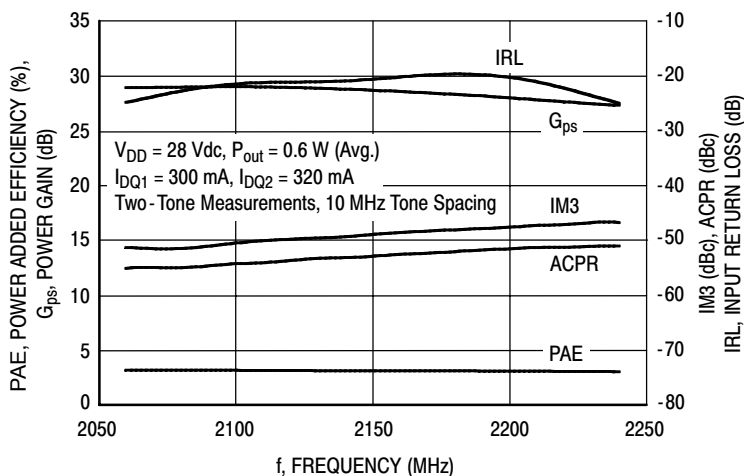


**Figure 4. MW6IC2240NBR1(GNBR1) Test Circuit Component Layout**

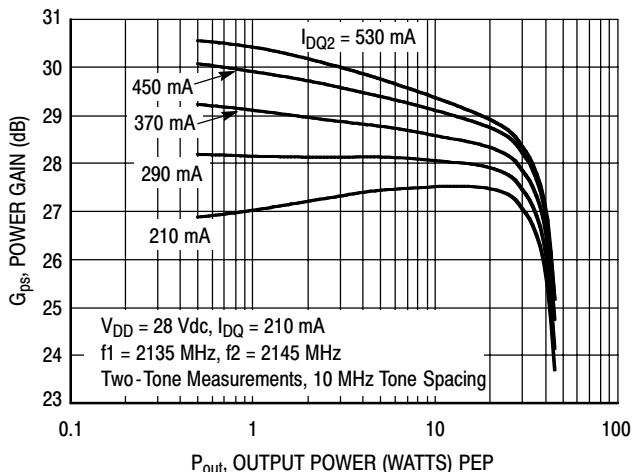
## TYPICAL CHARACTERISTICS



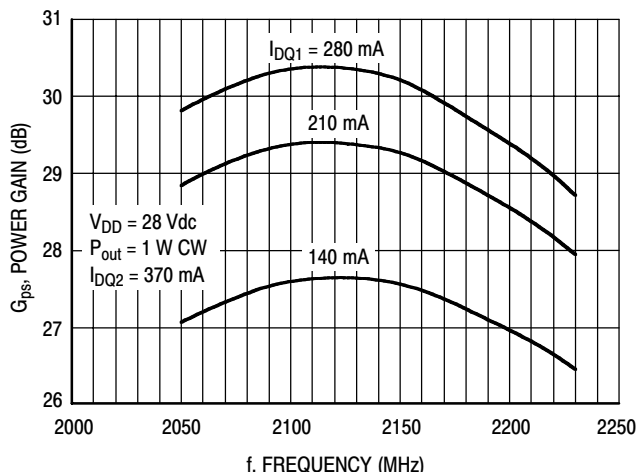
**Figure 5. 2-Carrier W-CDMA Wideband Performance @  $P_{out} = 4.5$  Watts Avg.**



**Figure 6. 2-Carrier W-CDMA Wideband Performance @  $P_{out} = 0.6$  Watts Avg.**

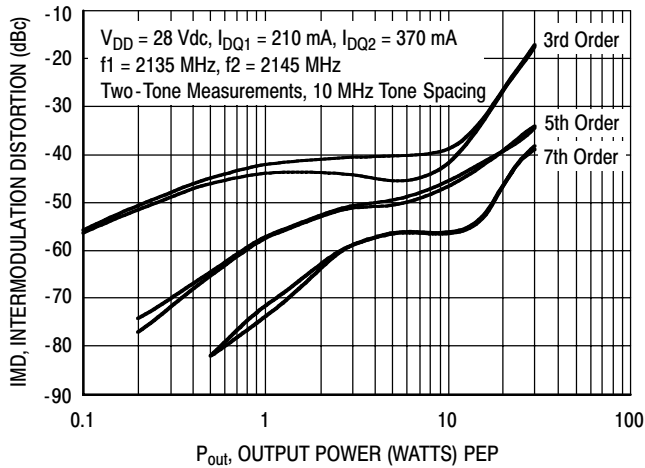


**Figure 7. Two-Tone Power Gain versus Output Power**

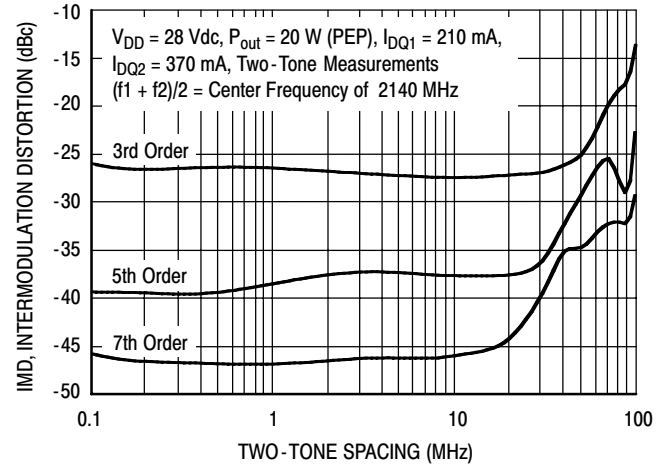


**Figure 8. Frequency Response versus Current**

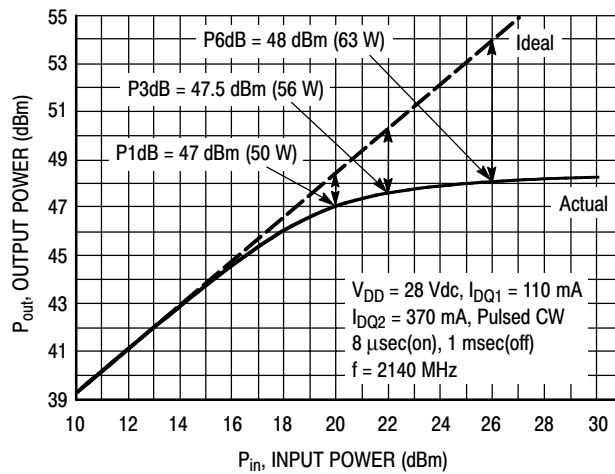
## TYPICAL CHARACTERISTICS



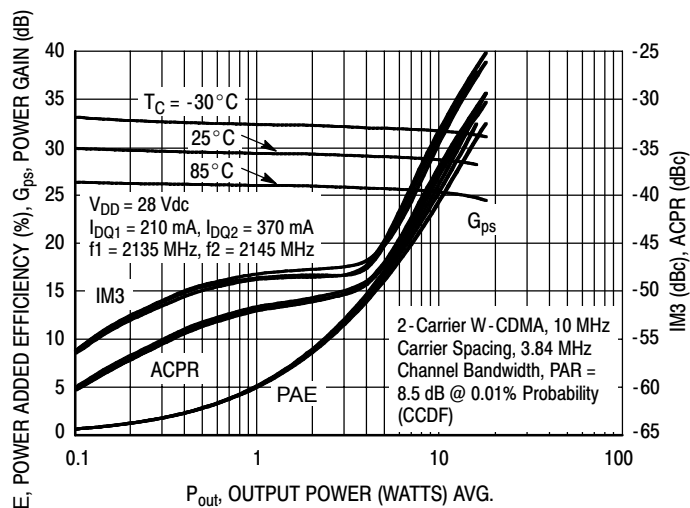
**Figure 9. Intermodulation Distortion Products versus Output Power**



**Figure 10. Intermodulation Distortion Products versus Tone Spacing**

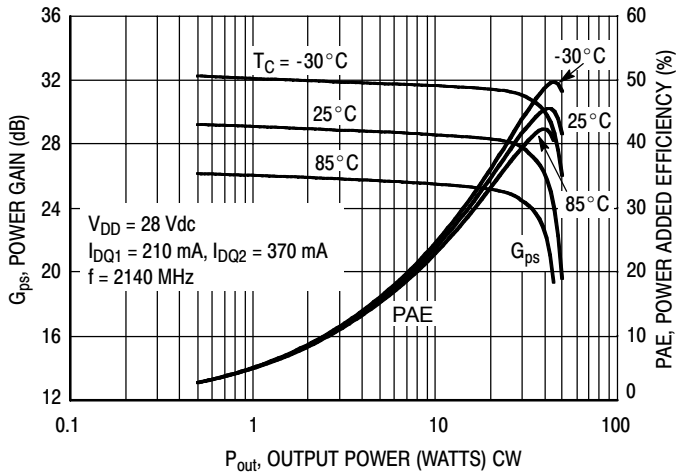


**Figure 11. Pulsed CW Output Power versus Input Power**

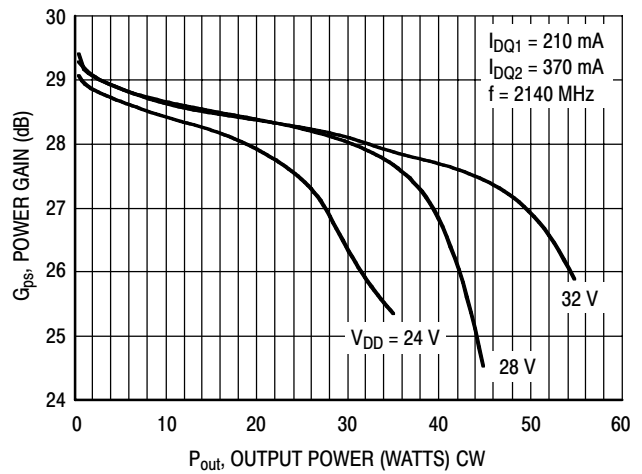


**Figure 12. 2-Carrier W-CDMA ACPR, IM3, Power Gain and Power Added Efficiency versus Output Power**

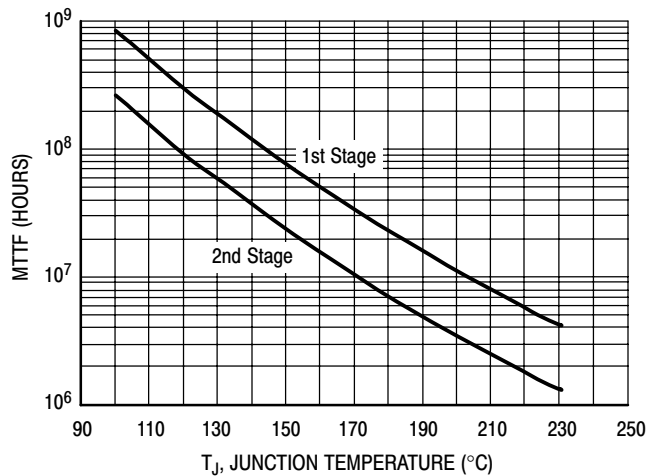
## TYPICAL CHARACTERISTICS



**Figure 13. Power Gain and Power Added Efficiency versus Output Power**



**Figure 14. Power Gain versus Output Power**

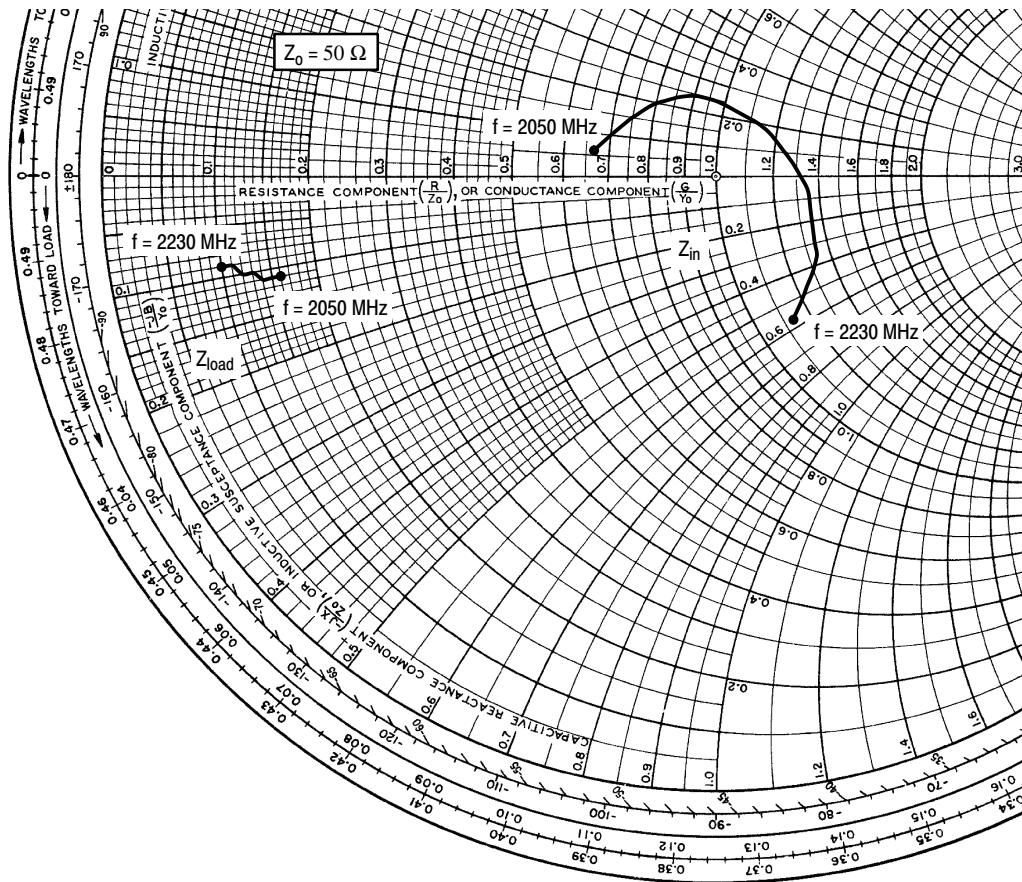


This above graph displays calculated MTTF in hours when the device is operated at  $V_{DD} = 28$  Vdc,  $P_{out} = 4.5$  W Avg., and PAE = 15%.

MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.

**Figure 15. MTTF versus Junction Temperature**





$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ1} = 210 \text{ mA}$ ,  $I_{DQ2} = 370 \text{ mA}$ ,  $P_{out} = 4.5 \text{ W Avg.}$

f MHz	$Z_{in}$ $\Omega$	$Z_{load}$ $\Omega$
2050	$33.723 + j3.048$	$7.971 - j5.705$
2080	$38.052 + j8.201$	$7.559 - j5.532$
2110	$45.972 + j12.306$	$7.117 - j5.345$
2140	$59.075 + j9.272$	$6.642 - j5.119$
2170	$68.368 - j3.227$	$6.132 - j4.891$
2200	$67.177 - j19.071$	$5.626 - j4.619$
2230	$58.213 - j28.879$	$5.118 - j4.305$

$Z_{in}$  = Device input impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

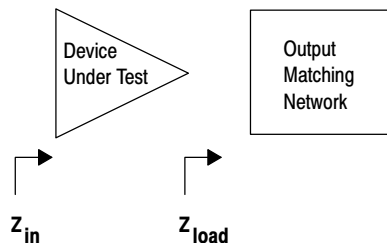


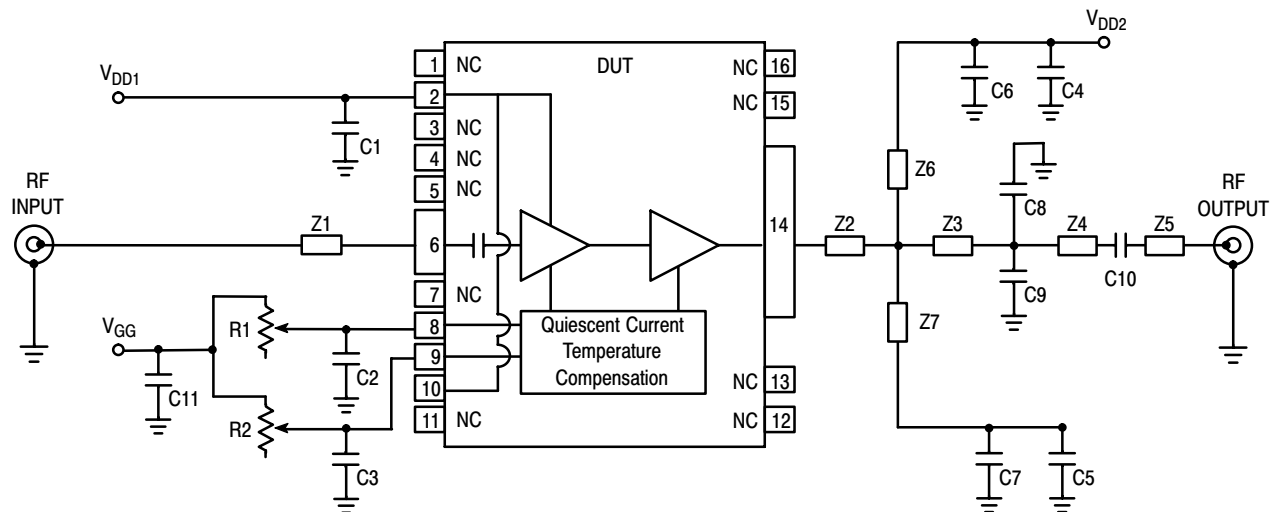
Figure 16. Series Equivalent Input and Load Impedance

**Table 8. Common Source Scattering Parameters ( $V_{DD} = 28\text{ V}$ , 50 ohm system)**

$I_{DQ1} = 210\text{ mA}$ ,  $I_{DQ2} = 370\text{ mA}$

f MHz	S <sub>11</sub>		S <sub>21</sub>		S <sub>12</sub>		S <sub>22</sub>	
	S <sub>11</sub>	∠ φ	S <sub>21</sub>	∠ φ	S <sub>12</sub>	∠ φ	S <sub>22</sub>	∠ φ
1000	0.788	131.360	0.0013	63.602	0.0020	25.353	0.9940	172.664
1200	0.713	113.326	0.0012	42.219	0.0094	10.742	0.9910	169.954
1400	0.584	86.885	0.0007	55.210	0.1180	-39.325	0.9850	166.452
1600	0.389	41.593	0.0006	117.726	0.6690	-92.822	0.9780	161.752
1800	0.239	-54.753	0.0022	122.409	4.9300	-164.584	0.9310	152.388
2000	0.221	-162.180	0.0036	118.178	21.396	49.432	0.6120	151.441
2200	0.216	-38.746	0.0057	68.626	19.739	-105.946	0.7530	-177.800
2400	0.467	-113.440	0.0043	64.758	7.8281	166.887	0.9010	171.868
2600	0.539	-153.020	0.0044	48.498	3.8868	113.310	0.9350	167.252
2800	0.635	-171.630	0.0044	52.829	2.4331	69.460	0.9480	164.137
3000	0.716	169.263	0.0049	56.398	1.6119	29.135	0.9570	161.593

## TD-SCDMA CHARACTERIZATION



Z1	1.180" x 0.056" Microstrip	Z5	0.727" x 0.056" Microstrip
Z2	0.136" x 0.237" Microstrip	Z6, Z7	1.066" x 0.078" Microstrip
Z3	0.096" x 0.237" Microstrip	PCB	Taconic TLX8, 0.020", $\epsilon_r = 2.55$
Z4	0.181" x 0.237" Microstrip		

**Figure 17. MW6IC2240NBR1(GNBR1) Test Circuit Schematic — TD-SCDMA**

**Table 9. MW6IC2240NBR1(GNBR1) Test Circuit Component Designations and Values — TD-SCDMA**

Part	Description	Part Number	Manufacturer
C1, C4, C5, C11	2.2 $\mu$ F Chip Capacitors	C3225X5R1H225MT	TDK
C2, C3	100 nF Chip Capacitors	C1206CK104K5RC	Kemet
C8, C9	1.2 pF Chip Capacitors	08051J1R2BBS	AVX
C10	6.8 pF Chip Capacitor	08051J6R8CBS	AVX
C6, C7	5.6 pF Chip Capacitors	08051J5R6CBS	AVX
R1, R2	5 k $\Omega$ Potentiometer CMS Cermet Multi-turn	3224W	Bourns

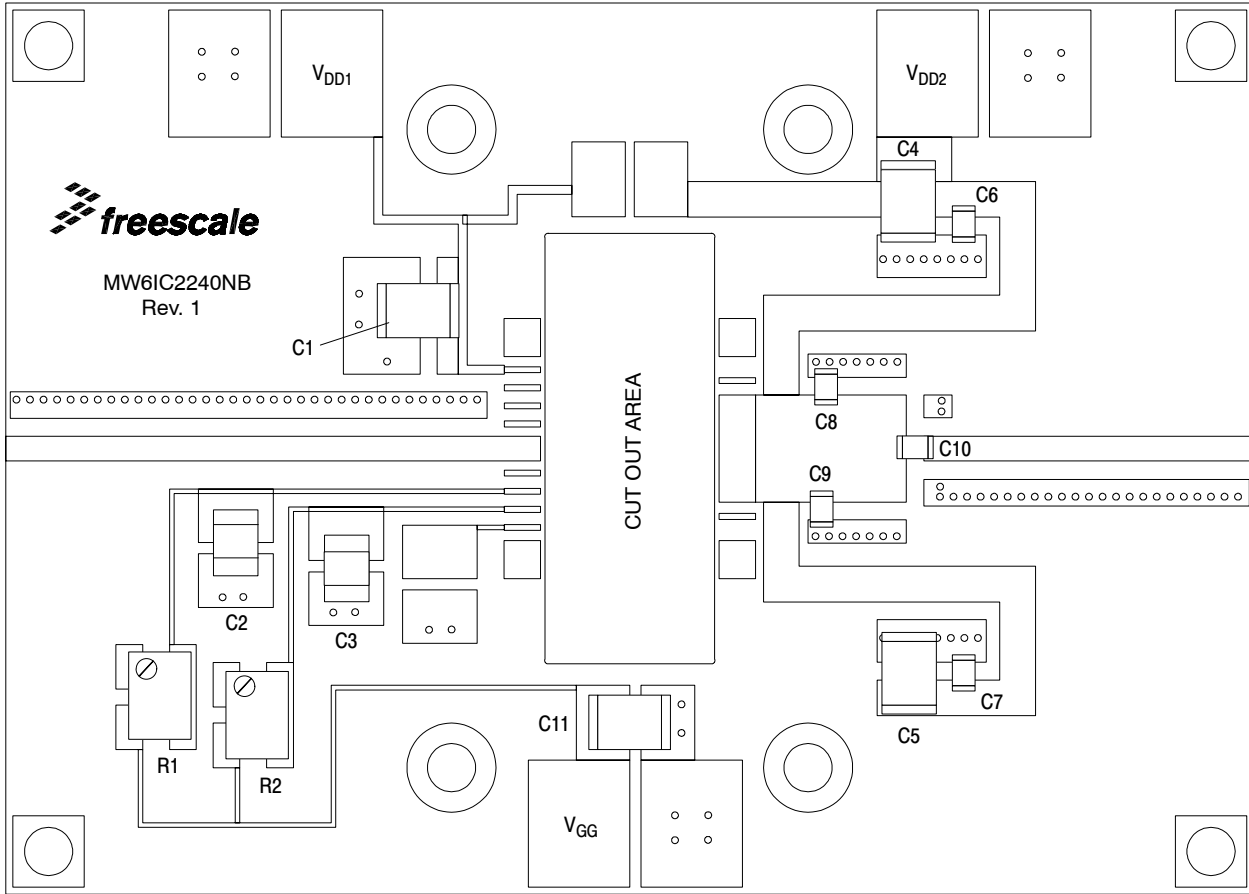
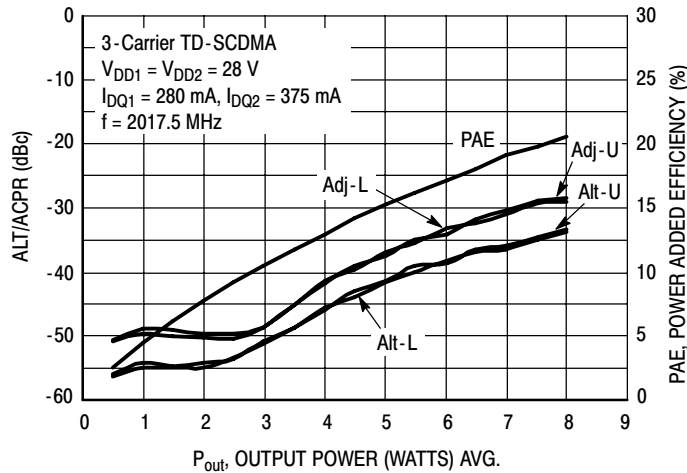
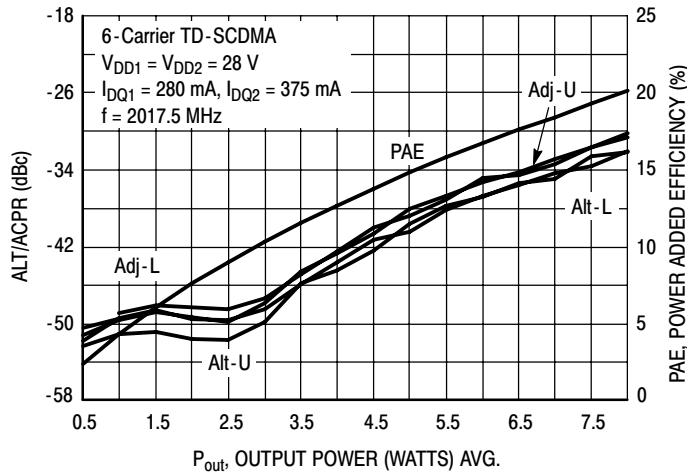


Figure 18. MW6IC2240NBR1(GNBR1) Test Circuit Component Layout — TD-SCDMA

## TYPICAL CHARACTERISTICS

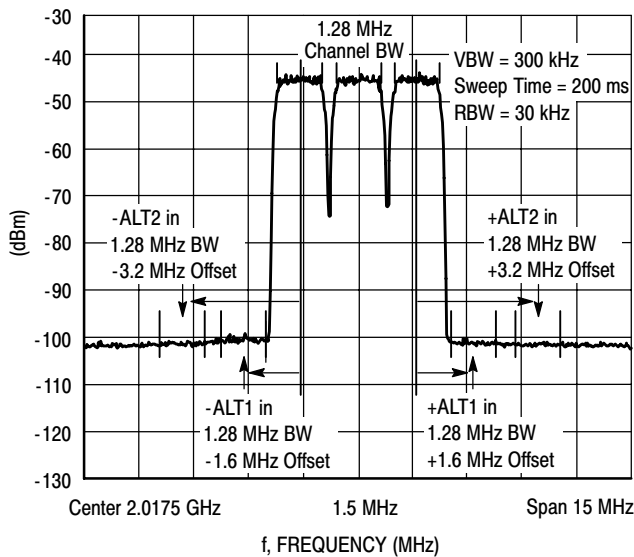


**Figure 19. 3-Carrier TD-SCDMA ACPR, ALT and Power Added Efficiency versus Output Power**

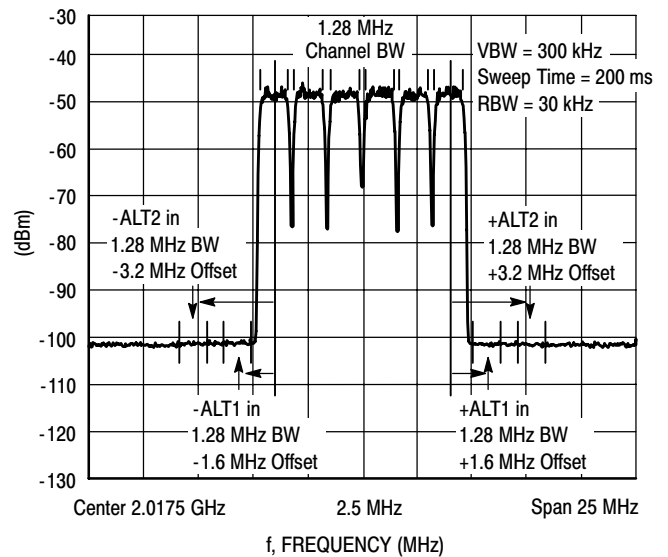


**Figure 20. 6-Carrier TD-SCDMA ACPR, ALT and Power Added Efficiency versus Output Power**

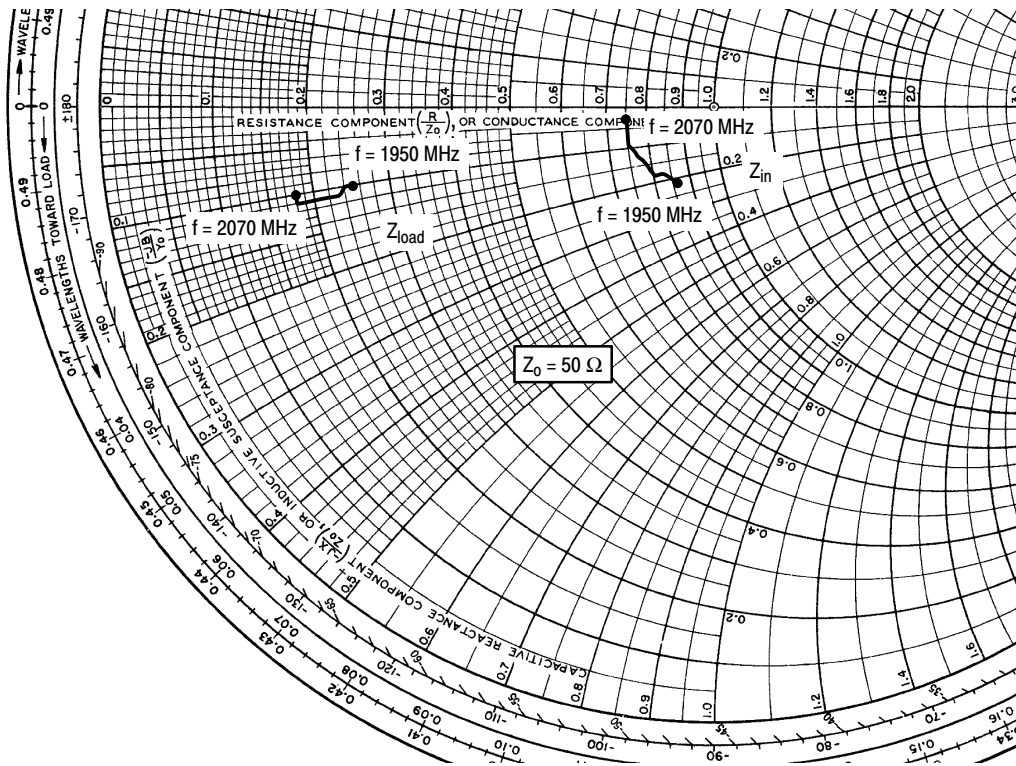
## TD-SCDMA TEST SIGNAL



**Figure 21. 3-Carrier TD-SCDMA Spectrum**



**Figure 22. 6-Carrier TD-SCDMA Spectrum**



$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ1} = 280 \text{ mA}$ ,  $I_{DQ2} = 375 \text{ mA}$

f MHz	$Z_{in}$ $\Omega$	$Z_{load}$ $\Omega$
1950	42.975 - j10.510	12.419 - j4.771
1960	41.871 - j9.592	12.233 - j5.001
1970	40.898 - j9.050	11.983 - j5.104
1980	40.084 - j8.816	11.683 - j5.368
1990	39.463 - j7.496	11.334 - j5.499
2000	38.859 - j6.587	10.959 - j5.585
2010	38.434 - j6.117	10.578 - j5.631
2020	38.096 - j4.972	10.212 - j5.635
2030	37.748 - j4.486	9.877 - j5.596
2040	37.553 - j3.046	9.575 - j5.536
2050	37.414 - j2.586	9.302 - j5.439
2060	37.369 - j1.918	9.053 - j5.319
2070	37.420 - j1.654	8.831 - j5.185

$Z_{in}$  = Device input impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

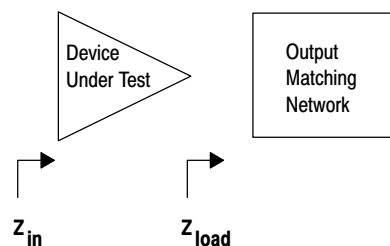
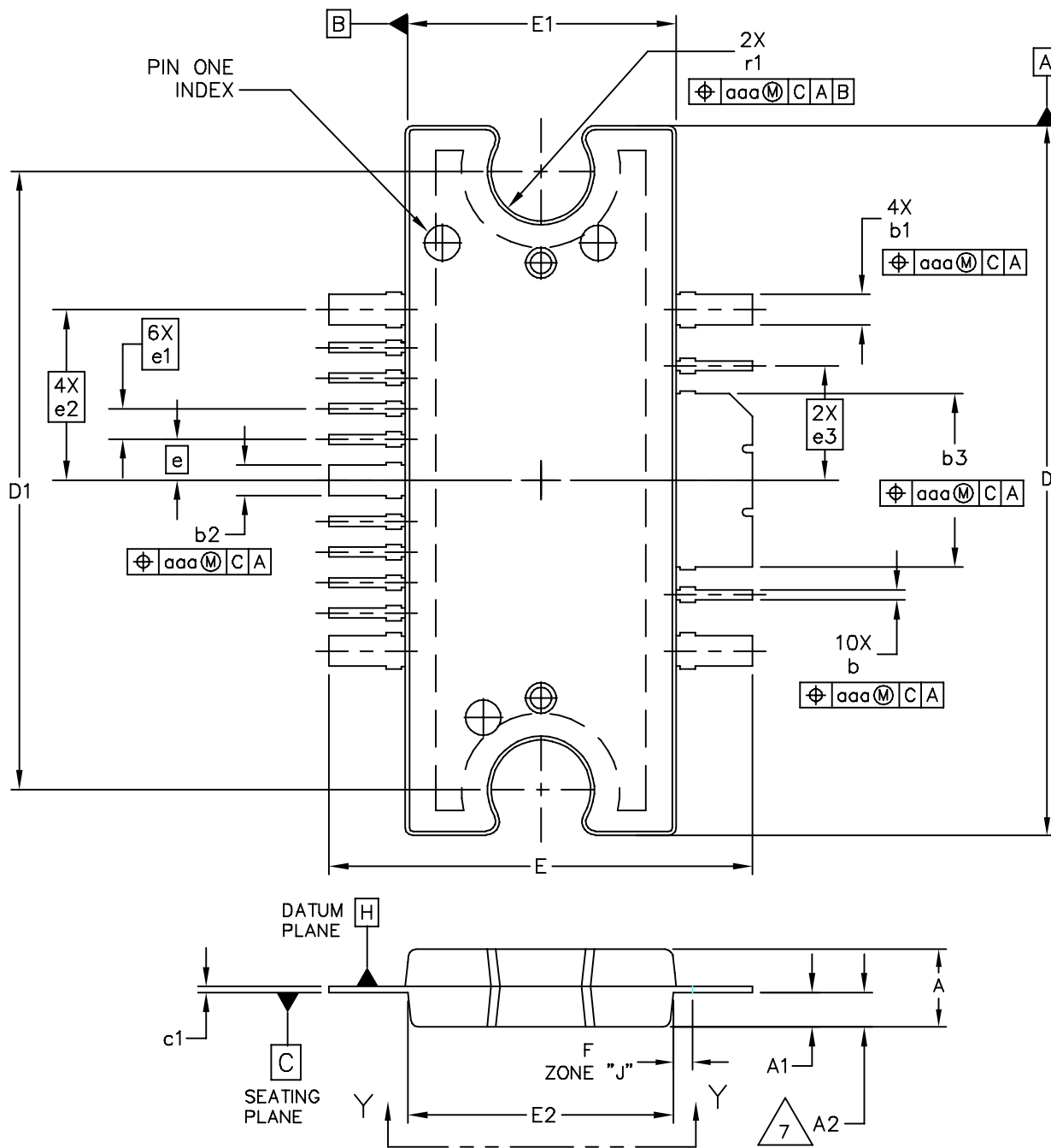


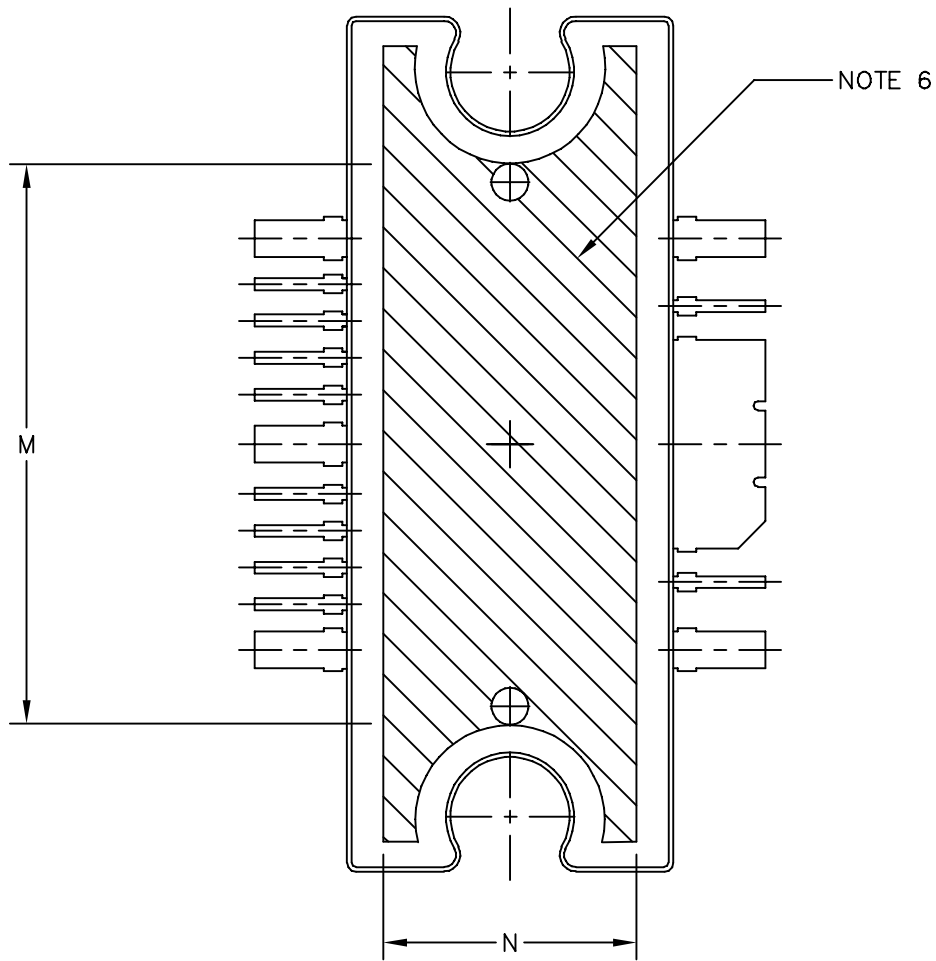
Figure 23. Series Equivalent Input and Load Impedance — TD-SCDMA

PACKAGE DIMENSIONS



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TITLE: TO-272 WIDE BODY MULTI-LEAD	DOCUMENT NO: 98ARH99164A	REV: L	
	CASE NUMBER: 1329-09	13 MAR 2006	
	STANDARD: NON-JEDEC		

MW6IC2240NBR1 MW6IC2240GNBR1



VIEW Y-Y

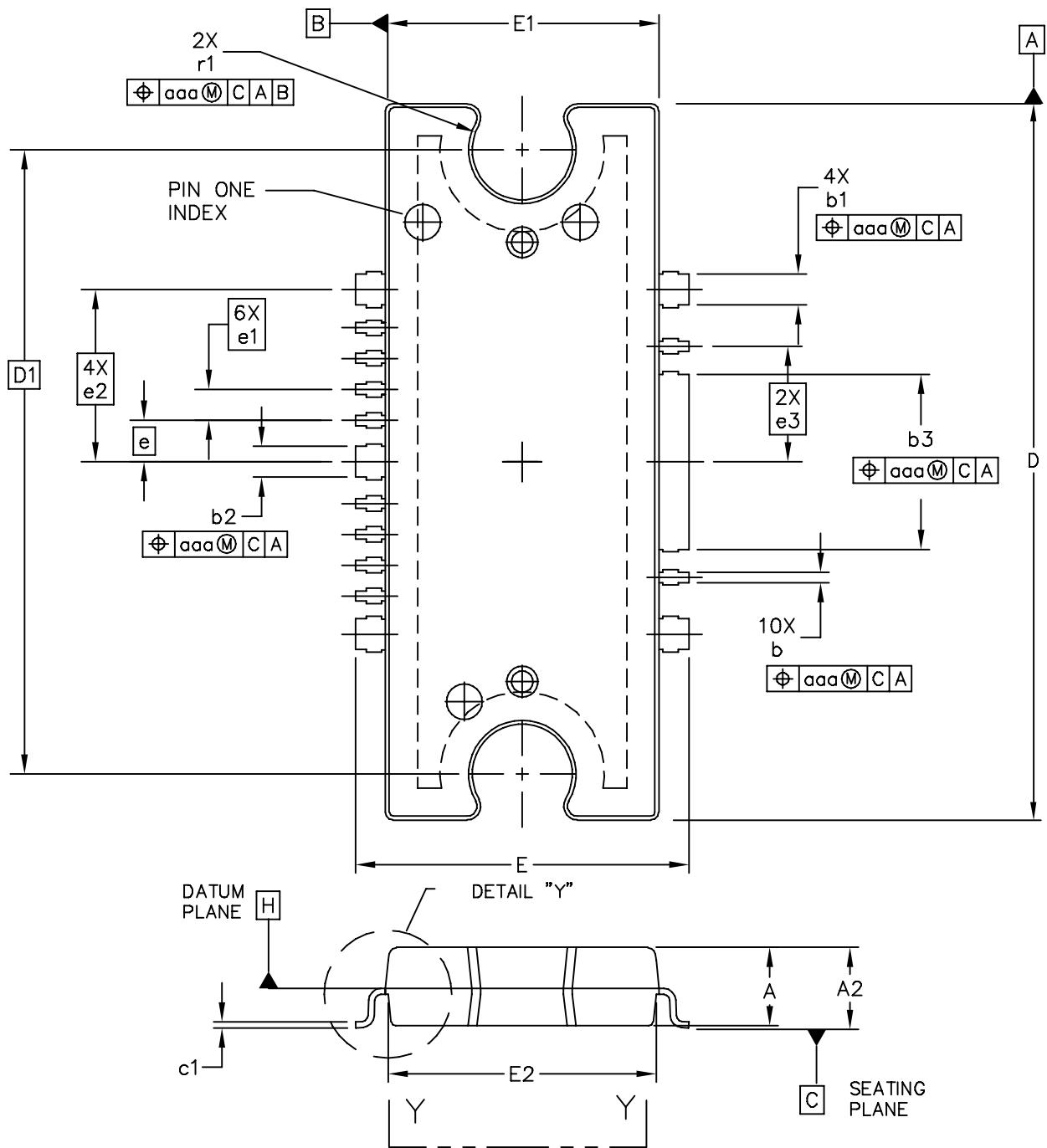
© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	<b>MECHANICAL OUTLINE</b>	PRINT VERSION NOT TO SCALE	
TITLE: TO-272 WIDE BODY MULTI-LEAD	DOCUMENT NO: 98ARH99164A	REV: L	
	CASE NUMBER: 1329-09	13 MAR 2006	
	STANDARD: NON-JEDEC		



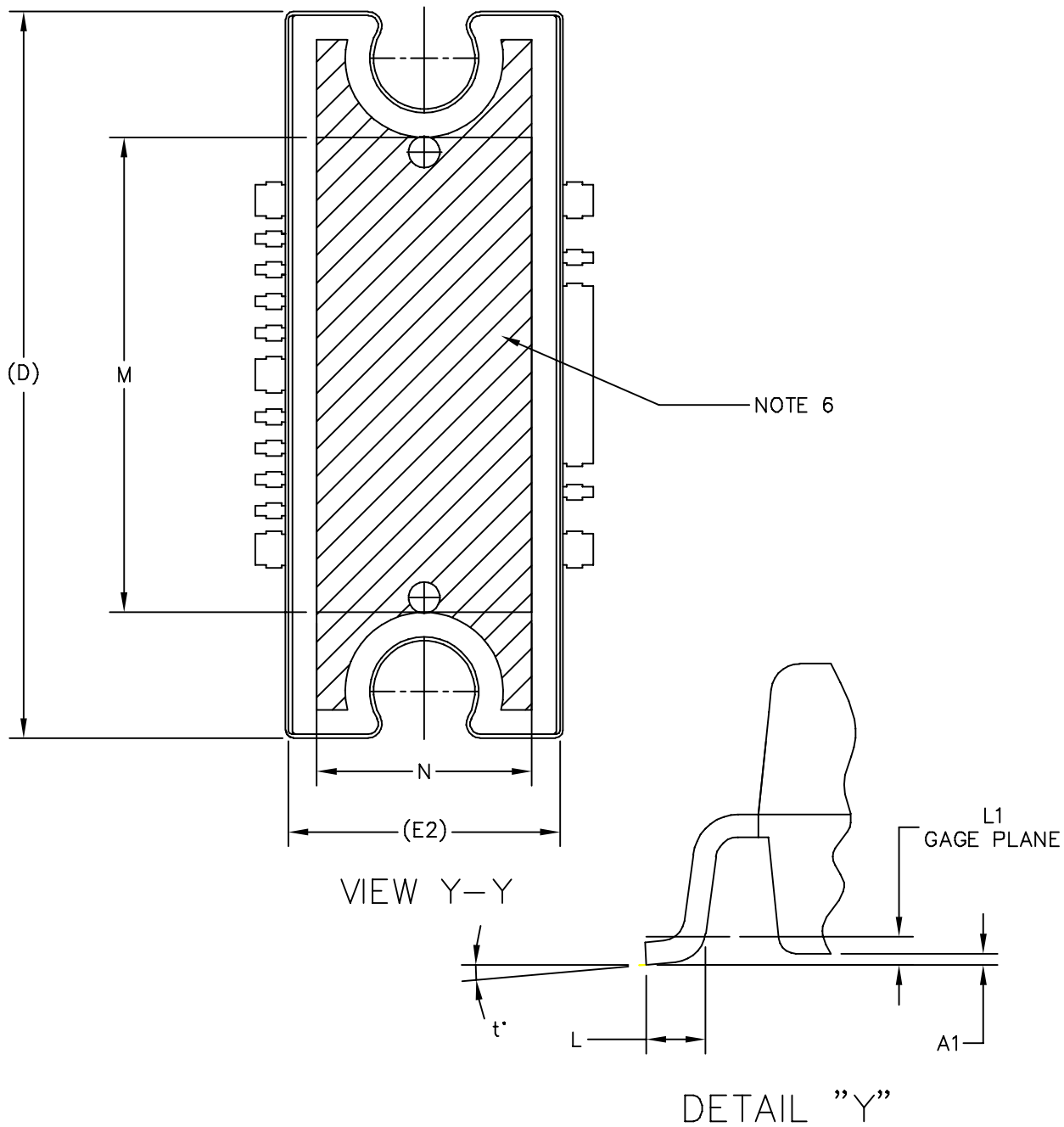
NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.
7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64	b	.011	.017	0.28	0.43
A1	.038	.044	0.96	1.12	b1	.037	.043	0.94	1.09
A2	.040	.042	1.02	1.07	b2	.037	.043	0.94	1.09
D	.928	.932	23.57	23.67	b3	.225	.231	5.72	5.87
D1	.810 BSC		20.57 BSC		c1	.007	.011	.18	.28
E	.551	.559	14.00	14.20	e	.054 BSC		1.37 BSC	
E1	.353	.357	8.97	9.07	e1	.040 BSC		1.02 BSC	
E2	.346	.350	8.79	8.89	e2	.224 BSC		5.69 BSC	
F	.025 BSC		0.64 BSC		e3	.150 BSC		3.81 BSC	
M	.600	----	15.24	----	r1	.063	.068	1.6	1.73
N	.270	----	6.86	----	aaa	.004		.10	
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	CASE NUMBER: 1329A-03	3 APR 2006	
	STANDARD: NON-JEDEC		

MW6IC2240NBR1 MW6IC2240GNBR1

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64	b	.011	.017	0.28	0.43
A1	.001	.004	0.02	0.10	b1	.037	.043	0.94	1.09
A2	.099	.110	2.51	2.79	b2	.037	.043	0.94	1.09
D	.928	.932	23.57	23.67	b3	.225	.231	5.72	5.87
D1	.810 BSC		20.57 BSC		c1	.007	.011	.18	.28
E	.429	.437	10.9	11.1	e	.054 BSC		1.37 BSC	
E1	.353	.357	8.97	9.07	e1	.040 BSC		1.02 BSC	
E2	.346	.350	8.79	8.89	e2	.224 BSC		5.69 BSC	
L	.018	.024	4.90	5.06	e3	.150 BSC		3.81 BSC	
L1	.01 BSC		.025 BSC		r1	.063	.068	1.6	1.73
M	.600	----	15.24	----	t	2'	8'	2'	8'
N	.270	----	6.86	----	aaa	.004		.10	
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					CASE NUMBER: 1329A-03			3 APR 2006	
					STANDARD: NON-JEDEC				

## PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

### Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN1977: Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN3263: Bolt Down Mounting Method for High Power RF Transistors and RFICs in Over-Molded Plastic Packages

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
3	Oct. 2006	<ul style="list-style-type: none"><li>• Added "including TD-SCDMA" to data sheet description, p. 1</li><li>• Added Part Number and Manufacturer to Resistors in Table 7, Component Designations and Values, p. 4</li><li>• Added TD-SCDMA test circuit schematic, component designations and values, component layout, typical characteristic curves, test signal and series impedance, p. 11-14</li><li>• Added Product Documentation and Revision History, p. 21</li></ul>
4	Dec. 2006	<ul style="list-style-type: none"><li>• Updated Part Numbers in Table 7, Component Designations and Values, to RoHS compliant part numbers, p. 4</li></ul>
5	Feb. 2007	<ul style="list-style-type: none"><li>• Corrected <math>V_{BIAS}</math> and <math>V_{SUPPLY}</math> callouts, Fig. 3, Test Circuit Schematic, p. 4, Fig. 4, Test Circuit Component Layout, p. 5</li><li>• Updated Part Numbers in Tables 7 and 9, Component Designations and Values, to RoHS compliant part numbers, p. 4, 11</li><li>• Removed lower voltage tests from Fig. 14, Power Gain versus Output Power, due to fixed tuned fixture limitations, p. 8</li><li>• Replaced Fig. 15, MTTF versus Junction Temperature with updated graph. Removed Amps<sup>2</sup> and listed operating characteristics and location of MTTF calculator for device, p. 8</li><li>• Changed callout <math>\eta_D</math> to PAE (Power Added Efficiency) for Figs. 19 and 20, 3-Carrier and 6-Carrier TD-SCDMA ACPR, ALT and Power Added Efficiency versus Output Power, p. 13</li><li>• Corrected <math>Z_{in}</math> data and plot in Fig. 23, Series Impedance, p. 14</li></ul>

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